

COMPOSITE TECHNOLOGIES FOR INTELLIGENT INDUSTRIAL LASER PROCESSING



prof. VINCENZO PIURI
Department of Information Technologies, University of Milan
via Bramante 65, 26013 Crema (CR), Italy



EU Project SLAPS
Self-Tuning and User-Independent
Laser Material Processing Units



Vincenzo Piuri, SLAPS/03, Houston, TX, USA, 19-21 November 2002

Information Sources Partners in IMS/Brite-Euram Project SLAPS

- Philips-CFT
- Laser Zentrum Hannover
- Odense Steel Shipyard LTD.
- Jurca Opto-elektronik
- Fiat-CRF

- Trumpf
- Lasag AG
- Politecnico di Milano
- Ecole Polytechnique Federale de Lausanne - IOA
- University of Vienna

Contributions to the Tutorial: Prof. Cesare Alippi, Politecnico di Milano, Italy
Dr. Toon Bloom, Philips CFT, The Netherlands

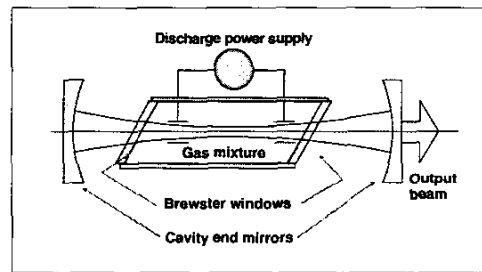
Vincenzo Piuri, SLAPS/03, Houston, TX, USA, 19-21 November 2002

Laser Processing Applying energy to a work piece in the form of (high intensity) light beam

- Laser seam welding
- Laser cutting
- Laser spot welding
- Laser drilling
- Laser cladding
- Laser marking
- Laser adjustment
-

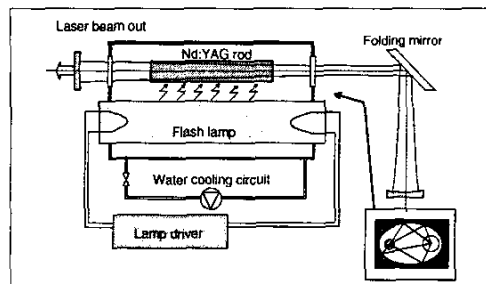
Vincenzo Piuri, SLAPS/03, Houston, TX, USA, 19-21 November 2002

Carbon Dioxide Laser Typical gas laser construction



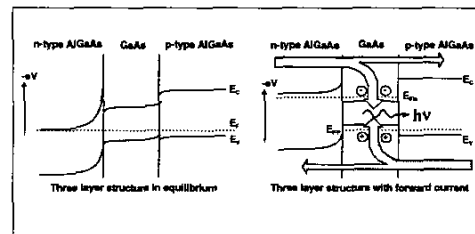
Vincenzo Piuri, SLAPS/03, Houston, TX, USA, 19-21 November 2002

Nd:YAG Laser



Vincenzo Piuri, SLAPS/03, Houston, TX, USA, 19-21 November 2002

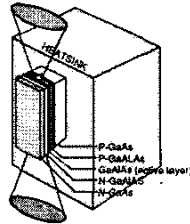
Solid State Laser Diode



Vincenzo Piuri, SLAPS/03, Houston, TX, USA, 19-21 November 2002

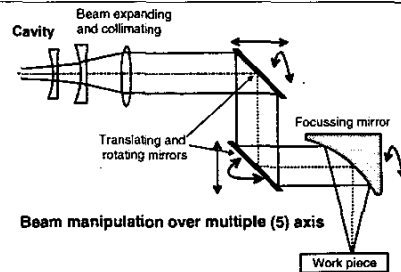
Solid State Laser Diode

- Low output power
- Laser diode arrays for processing
- Low beam quality
- Good control qualities
- High efficiency



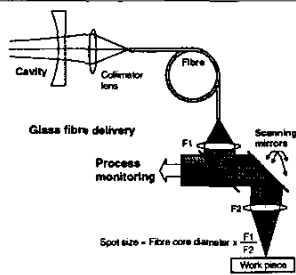
Vincennes Plant, Elcom/03, Houston, TX, USA, 18-21 November 2002

Beam Delivery



Vincennes Plant, Elcom/03, Houston, TX, USA, 18-21 November 2002

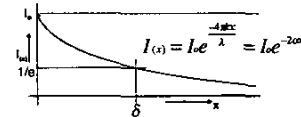
Beam Delivery



Vincennes Plant, Elcom/03, Houston, TX, USA, 18-21 November 2002

Absorption, Reflection, Transmission

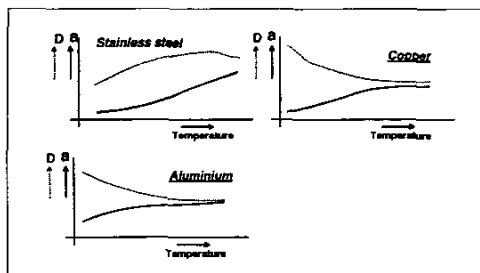
- Kirchhoff: Absorption + reflection + transmission = 1
- Extinction of the penetrating light wave



- Penetration depth: $\delta = \frac{1}{\alpha} = \frac{\lambda}{2\pi k} = \frac{\lambda c \epsilon_r}{\pi \sigma} = \frac{\lambda}{\pi \sigma \epsilon_r \mu} = \frac{1}{\pi \sigma \mu f}$

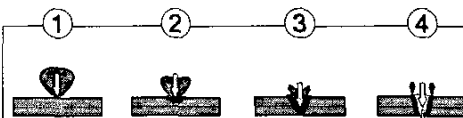
Vincennes Plant, Elcom/03, Houston, TX, USA, 18-21 November 2002

Absorption and Heat Diffusion = F(T)



Vincennes Plant, Elcom/03, Houston, TX, USA, 18-21 November 2002

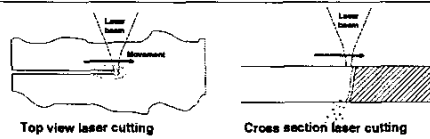
Process Phases



- 1: Heating: Absorption, heat diffusion
- 2: Phase transition of top material, change of properties
- 3: Vaporisation, recoil pressure pushes liquid metal aside
- 4: Liquid level reaches bottom and is blown out

Vincennes Plant, Elcom/03, Houston, TX, USA, 18-21 November 2002

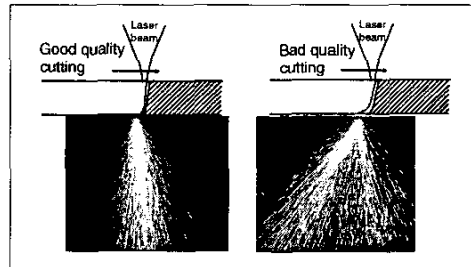
Laser Cutting



- Medium to high power CW lasers (CO_2)
- Process gas, reactive (O_2 extra reaction energy) or not (N_2), to blow out molten material
- Wave guide kind of energy transfer through the cutting slit

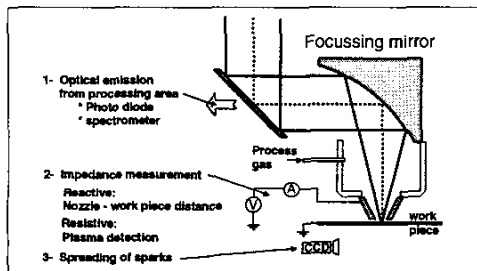
Vincennes Plant, #1200/03, Houston, TX, USA, 18-21 November 2003

Spark Pattern During Laser Cutting



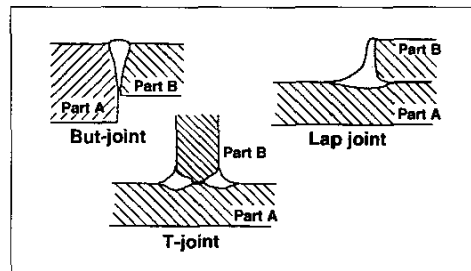
Vincennes Plant, #1200/03, Houston, TX, USA, 18-21 November 2003

Process Monitoring



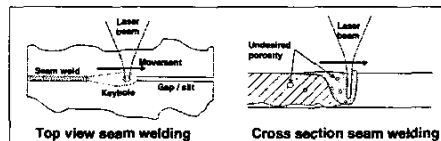
Vincennes Plant, #1200/03, Houston, TX, USA, 18-21 November 2003

Laser Seam Welding



Vincennes Plant, #1200/03, Houston, TX, USA, 18-21 November 2003

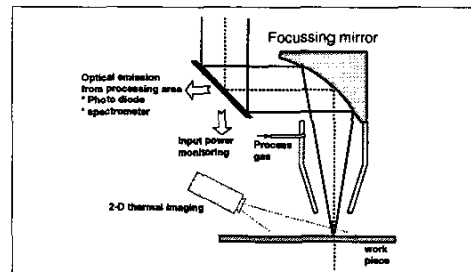
Laser Seam Welding



- Battery casings, Pace maker casings
- Car bodies, Transmission parts
- Sub assemblies in ship building
- Plastics (overlap penetration welding)

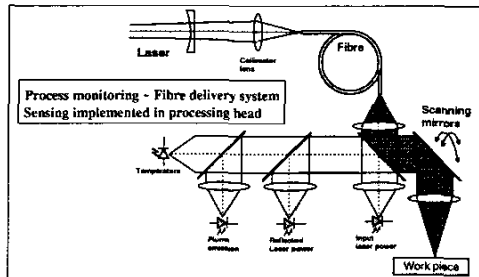
Vincennes Plant, #1200/03, Houston, TX, USA, 18-21 November 2003

Laser Seam Welding Process monitoring - Direct delivery system



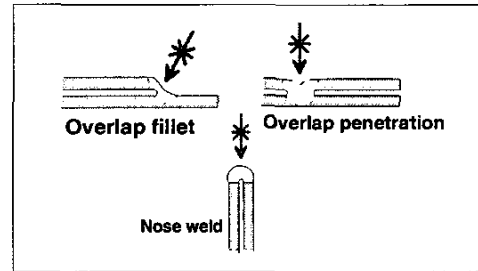
Vincennes Plant, #1200/03, Houston, TX, USA, 18-21 November 2003

Laser Seam Welding



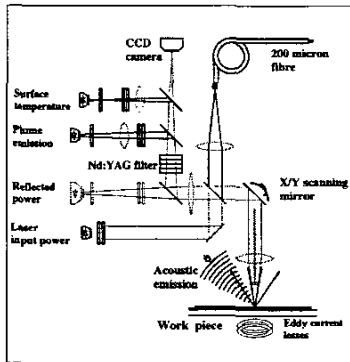
Vincennes Park, Elcom/DS, Houston, TX, USA, 18-21 November 2002

Spot Weld Geometries



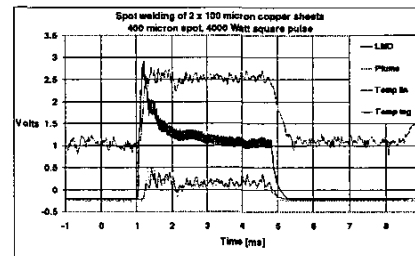
Vincennes Park, Elcom/DS, Houston, TX, USA, 18-21 November 2002

Process Monitoring in spot welding



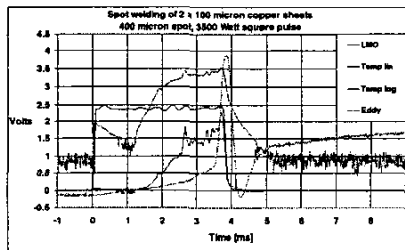
Vincennes Park, Elcom/DS, Houston, TX, USA, 18-21 November 2002

Signal Processing Example of measured signals



Vincennes Park, Elcom/DS, Houston, TX, USA, 18-21 November 2002

Signal Processing Example of measured signals



Vincennes Park, Elcom/DS, Houston, TX, USA, 18-21 November 2002

Automatic Classification based on multi sensor process monitoring

- The complete set of sensors provides a broad information range about the performance of the process
- Realisation of data reduction by extraction of specific features from the recorded signals
- The features are recognised as being related to certain process events
- The relations between features and a good or bad performing process have to be established through a large set of verification experiments

Vincennes Park, Elcom/DS, Houston, TX, USA, 18-21 November 2002

Requirements

- Accuracy
 - It measures the performance of the final solution according to a figure of merit to be defined
- In general, accuracy is not the unique goal to be pursued
- Computational load
 - Real time processing requirements
 - HW (HW Latency, Throughput)
 - SW (Flops, Worst case analysis)

Viswanath Murthy, ECE/UTCS, Houston, TX, USA, 18-21 November 2002

Requirements

- Modularity
 - Module reuse
 - Easy module up-grade
 - Homogeneity within the system
- Complexity of the Algorithm
 - Simplicity of the final solution
 - Latency
 - Easy implementation on a target dedicated processor (CISC, RISC, VLIW)
 - Easy HW implementation (ASIC, FPGA)

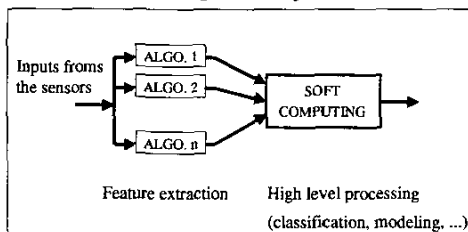
Viswanath Murthy, ECE/UTCS, Houston, TX, USA, 18-21 November 2002

Requirements

- Robustness (Sensitivity)
 - It measures the ability of the final algorithm to tolerate classes of perturbations
 - Fluctuations in the inputs (e.g., noise, non-stationarity of the process)
 - Perturbations affecting the computation (e.g., finite precision representations)
 - General purpose processor (Floating point representation)
 - DSP/Dedicated HW (Fixed point representation)
 - Analog implementation

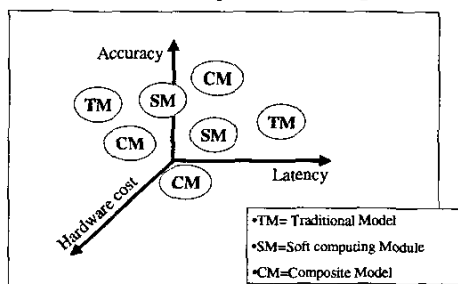
Viswanath Murthy, ECE/UTCS, Houston, TX, USA, 18-21 November 2002

A Composite System



Viswanath Murthy, ECE/UTCS, Houston, TX, USA, 18-21 November 2002

Models and Requirements Space



Viswanath Murthy, ECE/UTCS, Houston, TX, USA, 18-21 November 2002

Starting with Simple Models

- I would rather start with linear models
 - generally they are the simplest models
 - Linear regression (static)
 - AR(X), ARMA(X), Kalman Filters, etc (dynamic)
- Test the solution accuracy
 - with an appropriate figure of merit (e.g., MSE)
 - inspect the nature of the residual error
 - Anderson whiteness test
 - Kolmogorov Test
- Decide whether to accept the model/consider more complex/nonlinear models

Viswanath Murthy, ECE/UTCS, Houston, TX, USA, 18-21 November 2002

Move Towards Complex Models

- Non-linear models:
 - Leitmotiv: simplicity!
 - Static models
 - Supervised:
 - Feedforward NN, RBF
 - ...
 - Unsupervised
 - SOM, LVQ
 - ...
 - Note that predictive models not requiring the concept of state are considered to be static

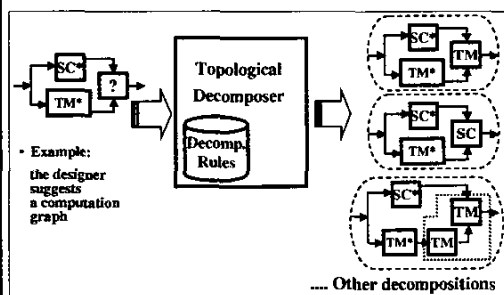
Virtues Plant, Elmer/02, Houston, TX, USA, 18-21 November 2002

Equation-based Models

- Equation-based Models
 - Most of times we forget that we can generate equation based models from physical/chemical principles.
 - We could start considering very simple models and test accuracy/ residual errors
 - More sophisticated models can be considered when necessary
 - Keep anyway in mind that we are in a constrained environment and there is the "time to market" concept.

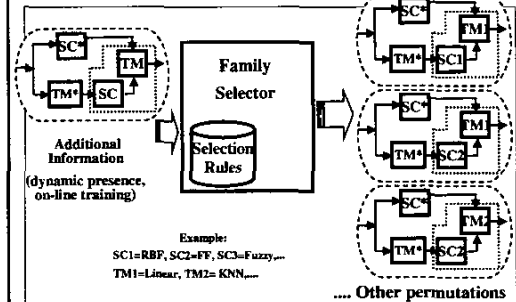
Virtues Plant, Elmer/02, Houston, TX, USA, 18-21 November 2002

Decomposition and Partitioning



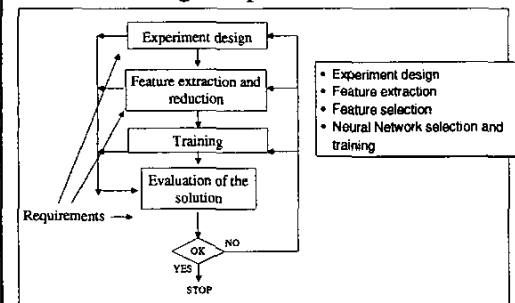
Virtues Plant, Elmer/02, Houston, TX, USA, 18-21 November 2002

Model Family Selection



Virtues Plant, Elmer/02, Houston, TX, USA, 18-21 November 2002

Training Unspecified Models



Virtues Plant, Elmer/02, Houston, TX, USA, 18-21 November 2002

Feature Extraction

• We need features to represent the information present in the sensorial signals in a compact way

- Advantages:
 - Information compression (less data to be further processed)
 - Input data reduction

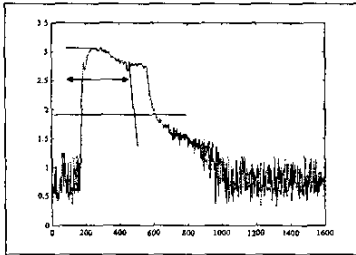
- Disadvantages:
 - Additional computational load in the feature extraction step

We want relevant and easy to be generated features.

Not always relevant features are computationally intensive

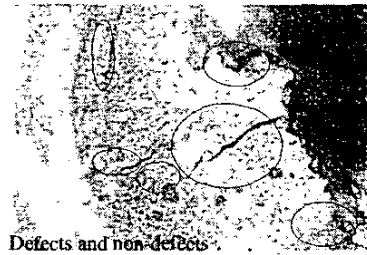
Virtues Plant, Elmer/02, Houston, TX, USA, 18-21 November 2002

Features Extraction: Example



Viatcheslav Pavlov, Elcom/02, Houston, TX, USA, 18-21 November 2002

Edge Detection in Images



Defects and non-defects

Viatcheslav Pavlov, Elcom/02, Houston, TX, USA, 18-21 November 2002

Features Selection

- Each classifier needs
 - a training phase
 - a validation phase to estimate its performance
- A “traditional” parameter adjusting procedure is not acceptable
- The problem can be solved with a heuristic based on the KNN classifiers

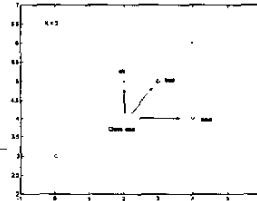
Viatcheslav Pavlov, Elcom/02, Houston, TX, USA, 18-21 November 2002

KNN Classifiers: Philosophy

- KNN = K Nearest Neighbours

- Basic Idea:

a pattern is classified based on the majority of the K nearest training patterns close to it



Viatcheslav Pavlov, Elcom/02, Houston, TX, USA, 18-21 November 2002

KNN Classifier

- It is an approximation of the optimal Bayes classifier ($N \rightarrow \infty$).
- The probability distributions are locally estimated based on each point
- KNN does not need a true training phase, since it “emerges” from available patterns once the parameters have been dimensioned
- Degrees of freedom:
 - number of class K
 - neighbourhood norm
 - selection of the K neighbourhood

Viatcheslav Pavlov, Elcom/02, Houston, TX, USA, 18-21 November 2002

The Algorithm: Description

0. U = set of all the features, $n = 1$
1. Build all the S_i subsets of U containing N features
2. For each S_i estimate the LOO performance of all the KNN classifiers with S_i as inputs (all combinations of preprocessings and K values up to a minimum)
3. Select those S_i which yield a performance better than a threshold; if only one S_i is selected goto 5...
4. ... else build their union U , increase n , and goto 1
5. Greedily grow S_i with the other features one by one, until no further performance improvement is scored
6. Select the best performing classifier

Viatcheslav Pavlov, Elcom/02, Houston, TX, USA, 18-21 November 2002

The Algorithm: Example

- Starting with 33 features:

Iteration	Classifier Error	Feature sets selected (K=1,3,5)
1	< 35%	3; 8; 20; 21; 23; 24; 32
2	< 25%	(3,8); (3,20); (3,32); (8,20); (8,24); (8,32); (20,32)
3	< 20%	(3,8,32); (3,20,32); (8,20,32)
4	-	(3,8,20,32)

- Adding all the other features to (3,8,20,32) one by one did not introduced further performance improvements
- Best KNN classifier:
 - inputs = (3,8,20,32), K = 5, estimated error = ~ 8-18%

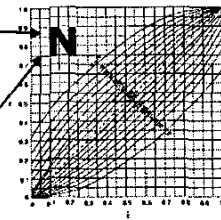
Vincenzo Flori, ESRM/02, Houston, TX, USA, 18-21 November 2002

Models Trained on Data

The parameterized models are tuned (Trained) using experimental data

ACCURACY
Cross-validation
(Some examples are used to test the performance of the model)

Interval of
Accuracy with 95%
confidence $A \pm a$
Based on the Bayesian Optimum
Classifier



Vincenzo Flori, ESRM/02, Houston, TX, USA, 18-21 November 2002

System Validation

- The system validation must be carried out by using
 - the whole system
 - the available (input,output) pairs
 - LOO (too expensive globally)
 - CV to be preferred instead
- If final performances do not satisfy the requirements we have to iterate the procedure by considering a different composite system

Vincenzo Flori, ESRM/02, Houston, TX, USA, 18-21 November 2002

LASER WELDING FOR AUTOMOTIVE COMPONENTS

This research has been carried out in collaboration with

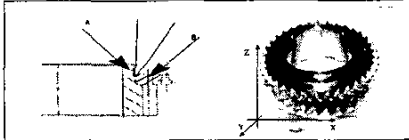


Fiat Research Centre, Turin, Italy

Vincenzo Flori, ESRM/02, Houston, TX, USA, 18-21 November 2002

The Application

- The gear is built by joining two separated rings (a light synchronization gear and the principal gear)
- Welding is carried out with a CO₂ laser



- Every product is tested using ultrasonic waves after welding for quality control

Vincenzo Flori, ESRM/02, Houston, TX, USA, 18-21 November 2002

The Application

- We wish on-line monitoring for
 - welding quality assessment
 - welding process monitoring (control)
- Welding problems are related to:
 - Penetration depth
 - Misalignment of coupling in mounted samples
 - Porosity
 - Power decrement up to 10%
 - Power lack up to 10 ms

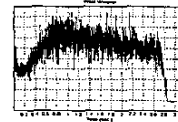
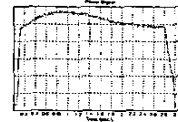
Vincenzo Flori, ESRM/02, Houston, TX, USA, 18-21 November 2002

The Application Requirements

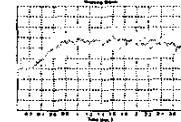
- The error categories can be grouped in three classes:
 - Power Loss
 - Mounting
 - Porosity
- Requirements:
 - High monitoring performance
 - Low computational load

Vincenzo Pirri, Elicon/O3, Houston, TX, USA, 18-21 November 2002

Signal Pre-Processing

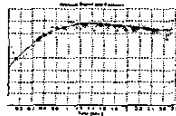
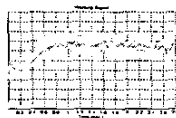


- Simple Processing
 - Amplitude Demodulation
 - Low Pass Filtering
- Fast Processing
 - 15K samples



Vincenzo Pirri, Elicon/O3, Houston, TX, USA, 18-21 November 2002

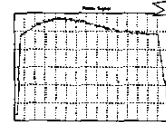
Feature Extraction



- Reference construction
 - a Cubic line has been considered to interpolate the relevant interval of the weld watcher signal
- Processing
 - 1805697 Flops

Vincenzo Pirri, Elicon/O3, Houston, TX, USA, 18-21 November 2002

Power Errors and Features

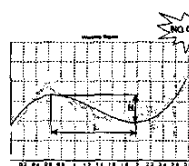
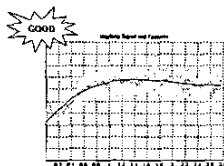


- Power Loss Errors
 - Short Duration of Welding Process
 - Laser Power Fluctuation
- Features
 - T: Duration of Effective Laser Power
 - F: Maximum Power Fluctuation



Vincenzo Pirri, Elicon/O3, Houston, TX, USA, 18-21 November 2002

Mount Errors and Features

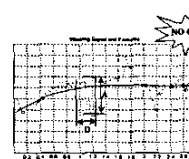
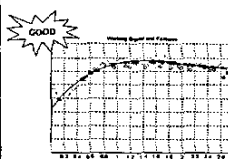


- Mount Errors
 - Modulation in Weld Watcher Signal

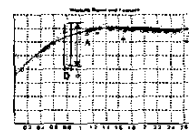
- Features
 - Parameters of the Cubic line
 - H-L: Cubic line Features

Vincenzo Pirri, Elicon/O3, Houston, TX, USA, 18-21 November 2002

Porosity Errors and Features



- Porosity Errors
 - Variations wrt to the reference signal
- Features
 - A: Amplitude of the discrepancy
 - D: Time duration of the discrepancy



Vincenzo Pirri, Elicon/O3, Houston, TX, USA, 18-21 November 2002

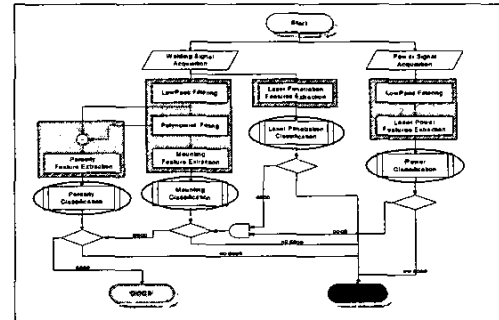
Remarks

- Few samples are available to configure the solution
- Not all samples can be classified by the operator
- The distribution of samples for the different error typologies is unknown

	Good	No Good	Not Classified	Total
Depth Error	31	9	29	69
Power Error	29	40	0	69
Mount Error	47	8	14	69
Porosity Error	275	10	60	345

Vincenzo Pieri, BSc/03, Houston, TX, USA, 18-21 November 2002

The Proposed Algorithm



Vincenzo Pieri, BSc/03, Houston, TX, USA, 18-21 November 2002

Experimental Results

	Classifier	Training	Cross Validation	Error of best classifier	Accuracy Interval	Notes
Depth	KNN	40 samples (100%)	39 samples (~100%)	0 %	~ 8 - 10 %	K= 1
	FRNN	28 samples (70%)	12 samples (30%)	0 %	~ 0 - 10 %	Neurons= 2 (Best over 100)
Power	KNN	69 samples (100%)	68 samples (~100%)	0 %	~ 0 - 8 %	K= 1
	FRNN	48 samples (70%)	21 samples (30%)	0 %	~ 0 - 8 %	Neurons= 4 (Best over 100)
Mount	KNN	55 samples (100%)	54 samples (~100%)	1.8 %	~ 0 - 10 %	K= 1
	FRNN	39 samples (70%)	16 samples (30%)	0 %	~ 0 - 8 %	Neurons= 2 (Best over 100)
Porosity	KNN	215 samples (100%)	214 samples (~100%)	0.35 %	~ 0 - 4 %	K= 1
	FRNN	199 samples (90%)	86 samples (30%)	0 %	~ 0 - 4 %	Neurons= 4 (Best over 100)

Vincenzo Pieri, BSc/03, Houston, TX, USA, 18-21 November 2002

SPARKS ANALYSIS FOR LASER CUTTING

This research has been carried out in collaboration with

TRUMPF, Ditzingen (Stuttgart), Germany

Vincenzo Pieri, BSc/03, Houston, TX, USA, 18-21 November 2002

The Application

- Laser cutting of steel/stainless steel is a complex process
- It is expected that monitoring of the sparks dynamic associated with the cutting process can provide hints about
 - The internal nature of the cutting process
 - Indications for subsequent process monitoring and control



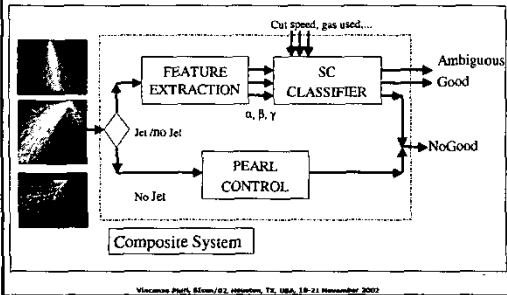
Vincenzo Pieri, BSc/03, Houston, TX, USA, 18-21 November 2002

The Application Requirements

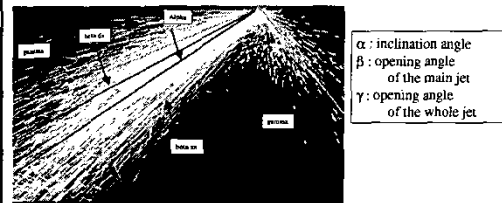
- There are three cutting error categories:
 - Good
 - No Good
 - Discontinuous cut
 - Pearls of metal
 - Ambiguous
- Requirements:
 - High Accuracy
 - Low computational load

Vincenzo Pieri, BSc/03, Houston, TX, USA, 18-21 November 2002

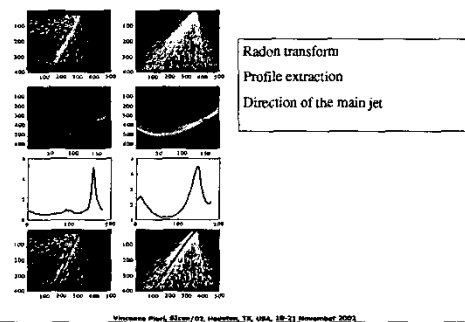
Composite System Partitioning



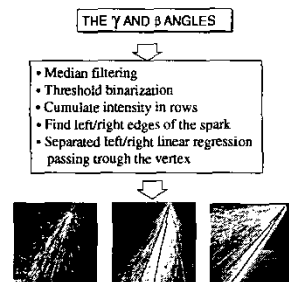
Features Extraction



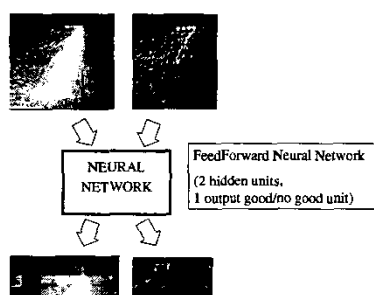
Finding the Jet Starting Point



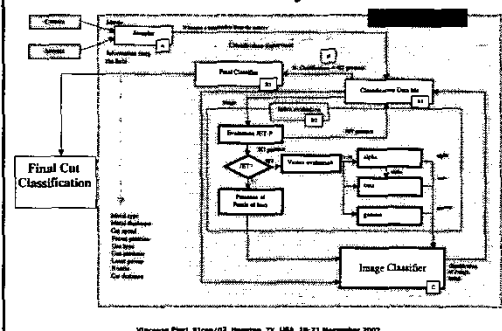
Estimating the Angles



Pearl Identification



The Final System



Performance

	Performance	Note
processing α, β, γ	Error < 3°	Using human estimates over 121 images the behavior of the angles-processing module fits suitably the sparks
Pearls	39/30	Using validation images
Classification good/no good/ambiguous	84/84	

Vincennes Plant, 61cm/02, Houston, TX, USA, 19-21 November 2002

LASER SPOT WELDING FOR ELECTRONIC COMPONENTS

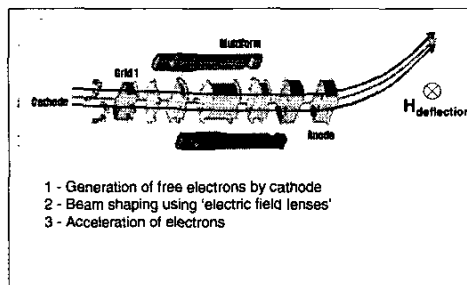
This research has been carried out in
collaboration with



Philips CFT - Centre for Industrial Technology

Vincennes Plant, 61cm/02, Houston, TX, USA, 19-21 November 2002

Electron Gun for Cathode Ray Tube



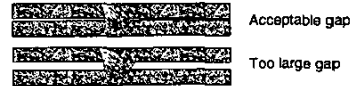
- 1 - Generation of free electrons by cathode
- 2 - Beam shaping using 'electric field lenses'
- 3 - Acceleration of electrons

Vincennes Plant, 61cm/02, Houston, TX, USA, 19-21 November 2002

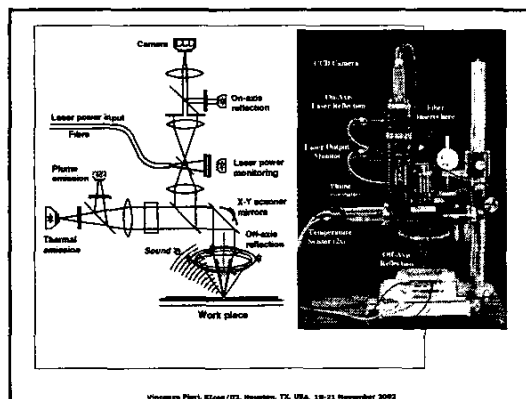
Manual Classification



Top view spot weld Bottom view spot weld OK Bottom view spot weld bad

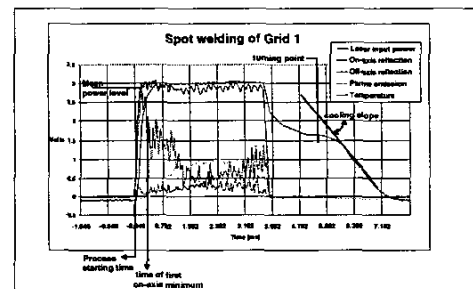


Vincennes Plant, 61cm/02, Houston, TX, USA, 19-21 November 2002



Vincennes Plant, 61cm/02, Houston, TX, USA, 19-21 November 2002

Feature Extraction



Vincennes Plant, 61cm/02, Houston, TX, USA, 19-21 November 2002

Automatic Classifiers

	Pros	Cons
Neural Networks	High accuracy	
K-Nearest Neighbor Classifier	No training required Does not necessarily lead to classifications	

Visage Part 8/00/02, Houston, TX, USA, 10/21 November 2002

Results from the Nearest Neighbour Classifier

	1NN		2NN		
	O.K.	N.O.K.	O.K.	??	N.O.K.
Strip	98.15	1.85	95.74	3.24	1.02
Strip (3)	97.67	2.33	95.63	3.20	1.17
Bracket	75.92	24.08	61.53	25.43	13.04
Bracket(15)	75.44	24.56	62.25	25.04	12.71
Curamik	84.86	15.14	73.06	19.64	7.30
Curamik(18)	86.04	13.96	75.01	17.14	7.85
MAI (32)	78.65	21.35	64.22	23.73	12.05
MAI (18)	77.37	22.63	63.70	24.75	11.55

Visage Part 8/00/02, Houston, TX, USA, 10/21 November 2002